

IPI120P04P4-04, IPP120P04P4-04

OptiMOS[®]-P2 Power-Transistor





Features

- P-channel Normal Level Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (RoHS compliant)
- 100% Avalanche tested

Product	Summary
---------	---------

V _{DS}	-40	V
R _{DS(on)} (SMD Version)	3.5	mΩ
I _D	-120	А

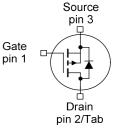
PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1



Туре	Package	Marking
IPB120P04P4-04	PG-TO263-3-2	4PP0404
IPI120P04P4-04	PG-TO262-3-1	4PP0404
IPP120P04P4-04	PG-TO220-3-1	4PP0404

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I _D	T _C =25°C, V _{GS} =-10V	-120	A
		T _C =100°C, V _{GS} =-10V ²⁾	-110	
Pulsed drain current ²⁾	I _{D,pulse}	7 _с =25°С	-480	
Avalanche energy, single pulse	E _{AS}	/ _D =-60A	78	mJ
Avalanche current, single pulse	I _{AS}	-	-120	А
Gate source voltage	V _{GS}	-	±20	V
Power dissipation	P _{tot}	7 _с =25 °С	136	W
Operating and storage temperature	T _j , T _{stg}	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	





IPI120P04P4-04, IPP120P04P4-04

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Thermal characteristics ²⁾						

Thermal resistance, junction - case	R_{thJC}	-	-	-	1.1	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	1
		6 cm ² cooling area ³⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, <i>I</i> _D = -1mA	-40	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = -340 \mu \text{A}$	-2.0	-3.0	-4.0	
Zero gate voltage drain current	I _{DSS}	V _{DS} =-32V, V _{GS} =0V, 7 _j =25°C	-	-0.05	-1	μA
		$V_{\rm DS}$ =-32V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C ²⁾	-	-20	-200	
Gate-source leakage current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	-	-	-100	nA
Drain-source on-state resistance	$R_{\rm DS(on)}$	V _{GS} =-10V, <i>I</i> _D =-100A	-	2.9	3.8	mΩ
		V _{GS} =-10V, <i>I</i> _D =-100A, SMD version	-	2.6	3.5	



IPI120P04P4-04, IPP120P04P4-04

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics²⁾

Input capacitance	C _{iss}		-	11380	14790	pF
Output capacitance	C _{oss}	V _{GS} =0V, V _{DS} =-25V, f=1MHz	-	3410	4430	
Reverse transfer capacitance	C _{rss}		-	90	180	
Turn-on delay time	t _{d(on)}		-	30	-	ns
Rise time	t _r	$V_{\rm DD}$ =-20V, $V_{\rm GS}$ =-10V, $I_{\rm D}$ =-120A, $R_{\rm G}$ =3.5 Ω	-	20	-	
Turn-off delay time	$t_{\rm d(off)}$		-	49	-	
Fall time	t _f		-	52	-	

Gate Charge Characteristics²⁾

Gate to source charge	Q _{gs}		-	62	80	nC
Gate to drain charge	Q _{gd}	V _{DD} =-32V, / _D =-120A,	-	30	60	
Gate charge total	Qg	$V_{\rm GS}$ =0 to -10V	-	158	205	
Gate plateau voltage	$V_{\rm plateau}$		-	-5.3	-	V

Reverse Diode

Diode continous forward current ²⁾	I _S	Т _с =25°С	-	-	-120	A
Diode pulse current ²⁾	I _{S,pulse}	/ _C -23 0	-	-	-480	
Diode forward voltage	$V_{\rm SD}$	V _{GS} =0V, / _F =-100A, 7 _j =25°C	-	-1	-1.3	V
Reverse recovery time ²⁾	t _{rr}	V _R =-20V, <i>I_F</i> =-50A, d <i>i_F</i> /d <i>t</i> =-100A/µs	-	69	-	ns
Reverse recovery charge ²⁾	Q _{rr}	d <i>i_F/dt=</i> -100A/µs	-	95	-	nC

¹⁾ Current is limited by bondwire; with an $R_{\text{thJC}} = 1.1$ K/W the chip is able to carry -155A at 25°C.

²⁾ Defined by design. Not subject to production test.

 $^{3)}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



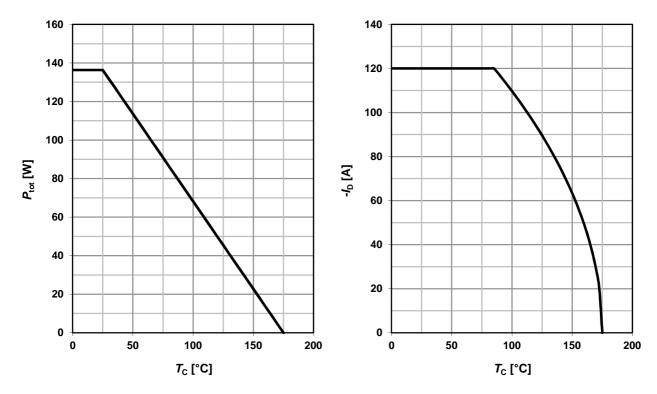
IPI120P04P4-04, IPP120P04P4-04

1 Power dissipation

 $P_{tot} = f(T_C); V_{GS} \le -6V$

2 Drain current

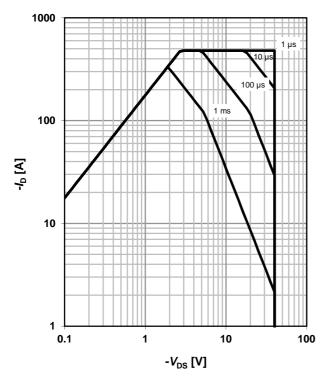
 $I_{\rm D} = f(T_{\rm C}); V_{\rm GS} \leq -6V; \text{SMD}$



3 Safe operating area

$$I_{\rm D} = f(V_{\rm DS}); T_{\rm C} = 25 \,^{\circ}\text{C}; D = 0; \text{SMD}$$

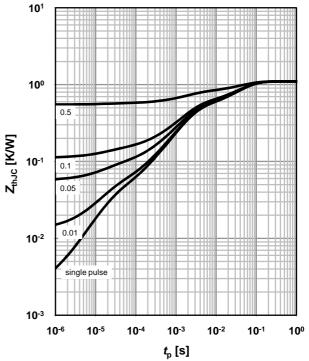
parameter: t_p



4 Max. transient thermal impedance

 $Z_{\rm thJC} = f(t_{\rm p})$

parameter: $D = t_p/T$





IPI120P04P4-04, IPP120P04P4-04

5 Typ. output characteristics

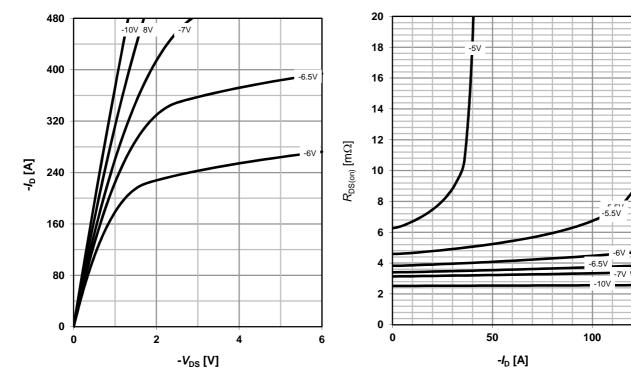
 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,^{\circ}\text{C}; \, \text{SMD}$

6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ °C}; SMD$

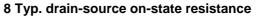
parameter: V_{GS}



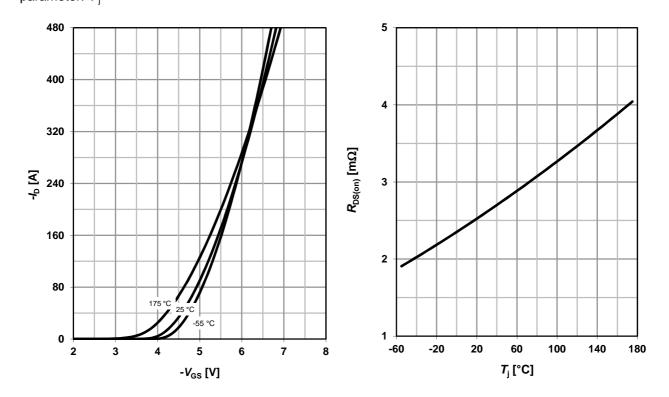


7 Typ. transfer characteristics

 $I_{\rm D} = f(V_{\rm GS}); V_{\rm DS} = -6V$ parameter: $T_{\rm j}$



 $R_{DS(on)} = f(T_j); I_D = -100 \text{ A}; V_{GS} = -10 \text{ V}; \text{ SMD}$





Ciss

Coss

Crss

30

IPI120P04P4-04, IPP120P04P4-04

9 Typ. gate threshold voltage

10 Typ. capacitances

1**0**5

10⁴

1**0**3

10²

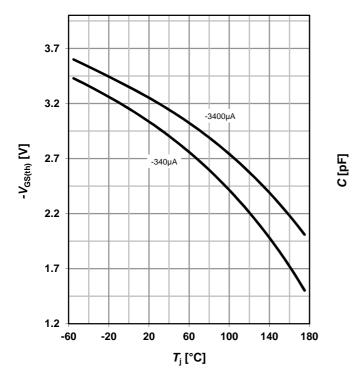
10¹

0

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

 $V_{\text{GS(th)}} = f(T_j); V_{\text{GS}} = V_{\text{DS}}$

parameter: I_D



11 Typical forward diode characteristicis

12 Drain-source breakdown voltage $V_{BR(DSS)} = f(T_j); I_D = -1 \text{ mA}$

5

10

15

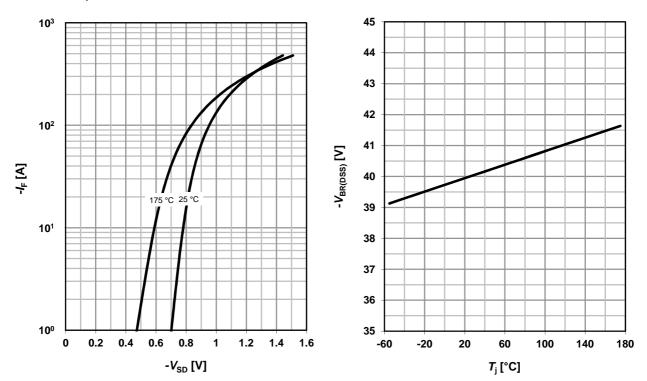
-V_{DS} [V]

20

25

 $I_F = f(V_{SD})$

parameter: T_i





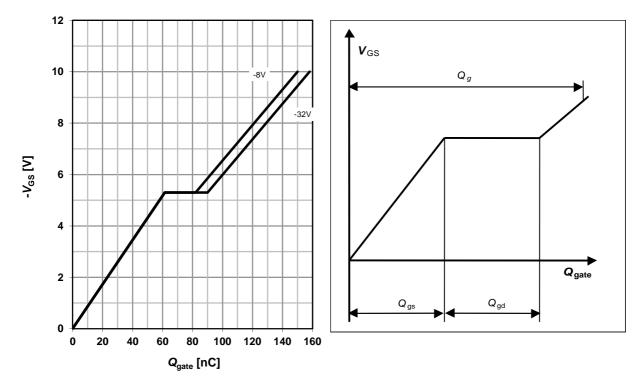
IPI120P04P4-04, IPP120P04P4-04

13 Typ. gate charge

14 Gate charge waveforms

 $V_{\rm GS} = f(Q_{\rm gate}); I_{\rm D} = -120$ A pulsed

parameter: V_{DD}





Published by Infineon Technologies AG 81726 Munich, Germany

© Infineon Technologies AG 2011 All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



IPI120P04P4-04, IPP120P04P4-04

Revision History

Version	Date	Changes
1.0	2011-01-25	Final Data Sheet
1.1	2015-05-27	Update of marking